

STS10PF30L

P-CHANNEL 30V - 0.012 Ω - 10A SO-8 STripFET™ II POWER MOSFET

ТҮРЕ	V _{DSS}	R _{DS(on)}	ID
STS10PF30L	30V	<0.014 Ω	10 A

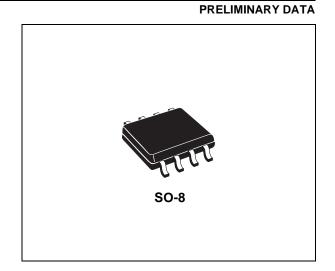
- TYPICAL R_{DS}(on) = 0.012 Ω
- STANDARDOUTLINEFOR EASY AUTOMATED SURFACE MOUNT ASSEMBLY
- LOW THRESHOLD DRIVE

DESCRIPTION

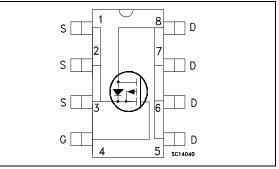
This Power MOSFET is the latest development of STMicroelectronis unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance.

APPLICATIONS

- BATTERY MANAGEMENT IN NOMADIC EQUIPMENT
- LOAD SWITCH



INTERNAL SCHEMATIC DIAGRAM



Ordering Information

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SALES TYPE	MARKING	PACKAGE	PACKAGING
STS10PF30L	S10PF30L	SO-8	TAPE & REEL

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source Voltage (V _{GS} = 0)	30	V
V _{DGR}	Drain-gate Voltage (R_{GS} = 20 k Ω)	30	V
V _{GS}	Gate- source Voltage	± 16	V
I _D	Drain Current (continuous) at $T_C = 25^{\circ}C$	10	А
ID	Drain Current (continuous) at $T_C = 100^{\circ}C$	6	А
I _{DM} (●)	Drain Current (pulsed)	40	А
P _{tot}	Total Dissipation at $T_C = 25^{\circ}C$	2.5	W

Note: For the P-CHANNEL MOSFET actual polarity of voltages and current has to be reversed

This is preliminary information on a new product now in development or undergoing evaluation. Details are subject to change without notice.

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THERMAL DATA

Rthj-amb Rthj-lead(*) Thermal Resistance Junction-ambient Thermal Resistance Junction-leads Maximum Lead Temperature For Soldering Purpos storage temperature	Max Max e Typ	47 16 150 -55 to 150	°C/W °C/W °C °C
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(*) When Mounted on 1 inch² FR-4 board, 2 oz of Cu and $t \leq$ 10 sec.

ELECTRICAL CHARACTERISTICS (T_{case} = 25 °C unless otherwise specified)

OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0$	30			V
I _{DSS}	Zero Gate Voltage Drain Current (V _{GS} = 0)	V_{DS} = Max Rating V_{DS} = Max Rating T _C = 125°C			1 10	μΑ μΑ
I _{GSS}	Gate-body Leakage Current (V _{DS} = 0)	V _{GS} = ± 16 V			±100	nA

ON (*)

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$	I _D = 250 μA	1			V
R _{DS(on)}	Static Drain-source On Resistance	V _{GS} = 10 V V _{GS} = 4.5 V	I _D = 5 A I _D = 5 A		0.012 0.015	0.014 0.018	Ω Ω

DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
g fs	Forward Transconductance	V _{DS} = 10 V I _D = 5 A		31		S
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	V _{DS} = 25V, f = 1 MHz, V _{GS} = 0		2300 750 115		pF pF pF

ELECTRICAL CHARACTERISTICS (continued)

SWITCHING ON (*)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on Delay Time Rise Time			72 87		ns ns
Q _g Q _{gs} Q _{gd}	Total Gate Charge Gate-Source Charge Gate-Drain Charge	V_{DD} = 15V I _D = 10A V _{GS} =4.5V (see test circuit, Figure 2)		29 6.8 7.6	39	nC nC nC

SWITCHING OFF (*)

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
t _{d(off)} t _f	Turn-off Delay Time Fall Time	$V_{DD} = 15 V$ $R_G = 4.7\Omega$, (Resistive Load	I _D = 5 A V _{GS} = 4.5 V , Figure 1)		89 27		ns ns

SOURCE DRAIN DIODE (*)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM}	Source-drain Current Source-drain Current (pulsed)				10 40	A A
V _{SD} (*)	Forward On Voltage	I _{SD} = 10 A V _{GS} = 0			1.2	V
t _{rr} Q _{rr} I _{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$\begin{split} I_{SD} &= 10 \text{ A} & \text{di/dt} = 100 \text{A}/\mu\text{s} \\ V_{DD} &= 15 \text{ V} & T_j = 150^\circ\text{C} \\ (\text{see test circuit, Figure 3}) \end{split}$		48.5 68 2.8		ns nC A

(*) Pulse width \leq 300 $\mu s,$ duty cycle 1.5 %. (•) Pulse width limited by T_{JMAX}

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Fig. 1: Switching Times Test Circuits For Resistive Load

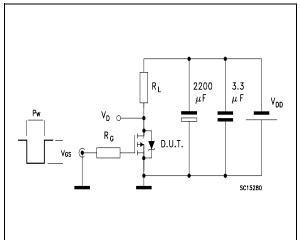


Fig. 3: Test Circuit For Diode Recovery Behaviour

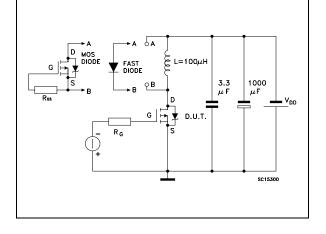
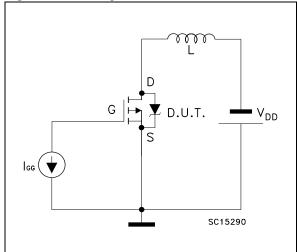


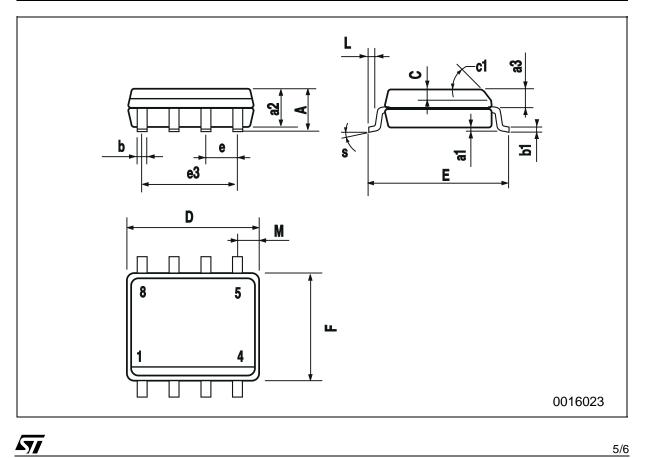
Fig. 2: Gate Charge test Circuit



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SO-8 MECHANICAL DATA

DIM.		mm			inch	
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
a3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
С	0.25		0.5	0.010		0.019
c1			45	(typ.)		
D	4.8		5.0	0.188		0.196
Е	5.8		6.2	0.228		0.244
е		1.27			0.050	
e3		3.81			0.150	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
М			0.6			0.023
S			8 (r	nax.)		



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